

SANYO Semiconductors DATA SHEET

2SA2207 — PNP Epitaxial Planar Silicon Transistor

50V / 13A High-Speed Switching Applications

Applications

· High-speed switching applications (switching regulators, drive circuit).

Features

- · Adoption of MBIT processes.
- · Large current capacitance.
- · Low collector-to-emitter saturation voltage.
- · High-speed switching.

Specifications

Absolute Maximum Ratings at Ta=25°C

Parameter	Symbol	Conditions	Ratings	Unit
Collector-to-Base Voltage	VCBO		-50	V
Collector-to-Emitter Voltage	VCEO		-50	V
Emitter-to-Base Voltage	VEBO		-6	V
Collector Current	IC		-13	Α
Collector Current (Pulse)	ICP		-15	Α
Base Current	lΒ		-2	Α
Collector Dissipation	De		1	W
	PC	Tc=25°C	20	W
Junction Temperature	Tj		150	°C
Storage Temperature	Tstg		-55 to +150	°C

Electrical Characteristics at Ta=25°C

Parameter	Symbol	Conditions		Ratings		
	Symbol		min	typ	max	Unit
Collector Cutoff Current	ICBO	V _{CB} =-40V, I _E =0A			-10	μΑ
Emitter Cutoff Current	I _{EBO}	V _{EB} =-4V, I _C =0A			-10	μΑ
DC Current Gain	hFE1	V _{CE} =-2V, I _C =-270mA	200		500	
	hFE2	VCE=-2V, IC=-8.1A	50			
Gain-Bandwidth Product	fT	V _{CE} =-5V, I _C =-700mA		110		MHz
Output Capacitance	Cob	V _{CB} =-10V, f=1MHz		100		pF

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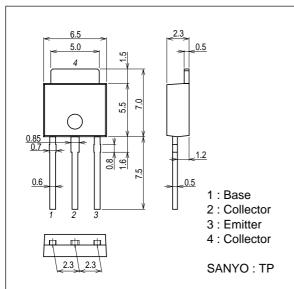
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Parameter	Symbol	Conditions	Ratings			Unit
			min	typ	max	Offic
Collector-to-Emitter Saturation Voltage	VCE(sat)	IC=-6A, IB=-300mA		-250	-500	mV
Base-to-Emitter Saturation Voltage	V _{BE} (sat)	I _C =-6A, I _B =-300mA			-1.2	V
Collector-to-Base Breakdown Voltage	V(BR)CBO	IC=-100μA, IE=0A	-50			V
Collector-to-Emitter Breakdown Voltage	V(BR)CEO	IC=-1mA, RBE=∞	-50			V
Emitter-to-Base Breakdown Voltage	V(BR)EBO	I _E =-100μA, I _C =0A	-6			V
Turn-ON Time	ton	See specified Test Circuit.		80		ns
Storage Time	t _{stg}	See specified Test Circuit.		265		ns
Fall Time	tf	See specified Test Circuit.		43		ns

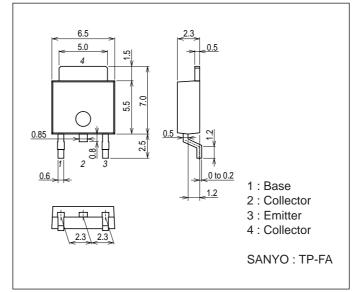
Package Dimensions

unit : mm (typ) 7518-003

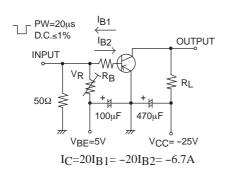


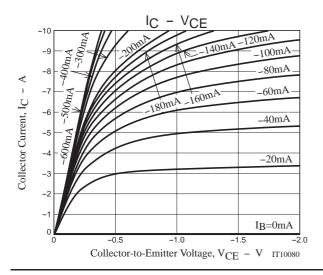
Package Dimensions

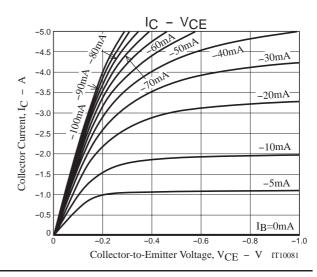
unit : mm (typ) 7003-003

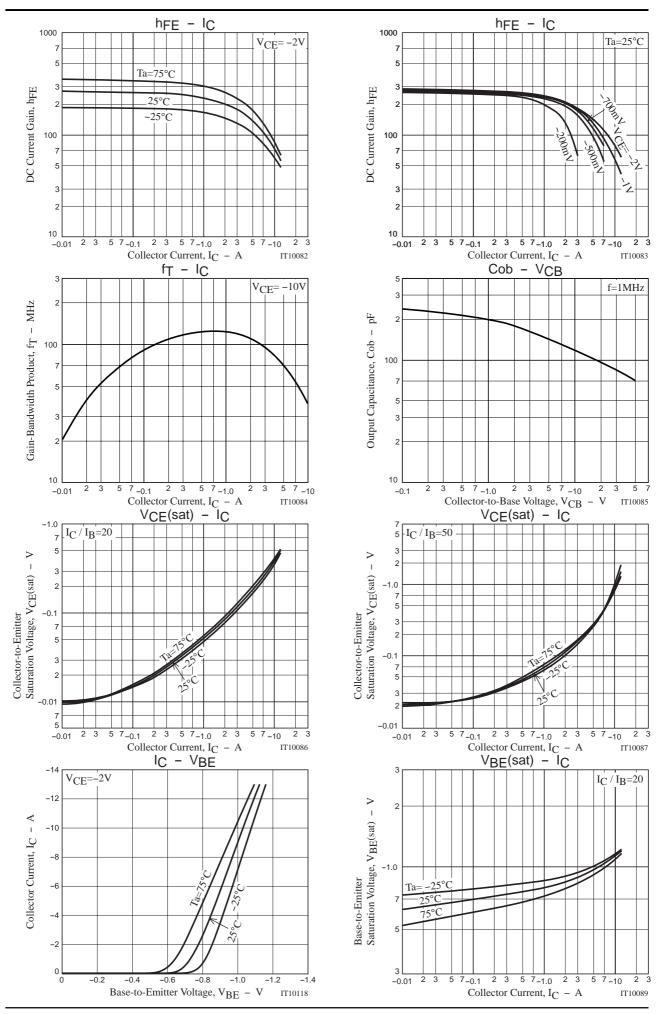


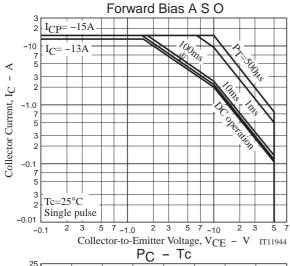
Switching Time Test Circuit

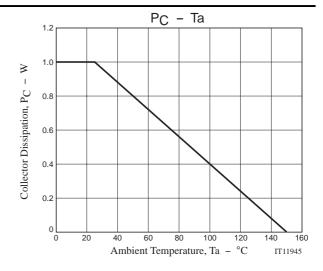


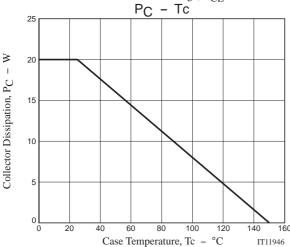












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